International **ISPR** Rectifier

- Advanced Process Technology
- Surface Mount (IRFZ48NS)
- Low-profile through-hole (IRFZ48NL)
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free

Description

Advanced HEXFET[®] Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The D²Pak is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highestpower capability and the lowestpossible on-resistance in any existing surface mount package. The D²Pak is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.

The through-hole version (IRFZ48NL) is available for low-profile applications.

Absolute Maximum Ratings

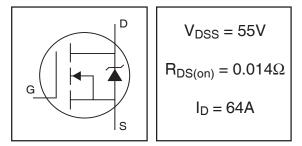
Parameter	Max.	Units
Continuous Drain Current, V _{GS} @ 10V	64	
Continuous Drain Current, V _{GS} @ 10V	45	A
Pulsed Drain Current ①	210	
Power Dissipation	3.8	W
Power Dissipation	130	W
Linear Derating Factor	0.83	W/°C
Gate-to-Source Voltage	± 20	V
Avalanche Current①	32	A
Repetitive Avalanche Energy①	13	mJ
Peak Diode Recovery dv/dt 3	5.0	V/ns
Operating Junction and	-55 to + 175	
Storage Temperature Range		°C
Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Continuous Drain Current, V _{GS} @ 10V Pulsed Drain Current ① Power Dissipation Linear Derating Factor Gate-to-Source Voltage Avalanche Current① Repetitive Avalanche Energy① Peak Diode Recovery dv/dt ③ Operating Junction and Storage Temperature Range	Continuous Drain Current, V_{GS} @ 10V45Pulsed Drain Current ①210Power Dissipation3.8Power Dissipation130Linear Derating Factor0.83Gate-to-Source Voltage ± 20 Avalanche Current①32Repetitive Avalanche Energy①13Peak Diode Recovery dv/dt ③5.0Operating Junction and-55 to + 175Storage Temperature Range

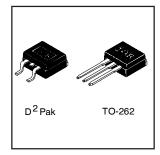
Thermal Resistance

	Parameter	Тур.	Max.	Units
R _{qJC}	Junction-to-Case		1.15	°C ///
R _{qJA}	Junction-to-Ambient (PCB Mounted,steady-state)**	·	40	°C/W
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PD - 95125

IRFZ48NSPbF IRFZ48NLPbF HEXFET® Power MOSFET





Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

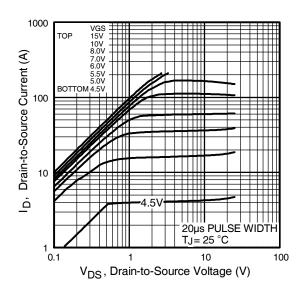
	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250 \mu A$
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.058		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			14	mΩ	$V_{GS} = 10V, I_D = 32A$ (4)
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
g _{fs}	Forward Transconductance	24			S	$V_{DS} = 25V, I_D = 32A^{\text{(4)}}$
I _{DSS}	Drain-to-Source Leakage Current			25	$\mu A = V_{DS} = 55V, V_{GS} = 0V$	$V_{DS} = 55V, V_{GS} = 0V$
1055	Brain to Cource Leanage Guneni			250	μΛ	$V_{DS} = 44V, V_{GS} = 0V, T_J = 150^{\circ}C$
1	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
IGSS	Gate-to-Source Reverse Leakage			-100		V _{GS} = -20V
Qg	Total Gate Charge			81		I _D = 32A
Q _{gs}	Gate-to-Source Charge			19	nC	$V_{DS} = 44V$
Q _{gd}	Gate-to-Drain ("Miller") Charge			30		V_{GS} = 10V, See Fig. 6 and 13
t _{d(on)}	Turn-On Delay Time		12			$V_{DD} = 28V$
tr	Rise Time		78		ns	I _D = 32A
t _{d(off)}	Turn-Off Delay Time		34		115	$R_G = 0.85\Omega$
t _f	Fall Time		50			V_{GS} = 10V, See Fig. 10 \circledast
L _S	Internal Source Inductance		7.5		nH	Between lead,
						and center of die contact
C _{iss}	Input Capacitance		1970			$V_{GS} = 0V$
C _{oss}	Output Capacitance		470			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		120		рF	f = 1.0MHz, See Fig. 5
E _{AS}	Single Pulse Avalanche Energy [®]		700⑤	1906	mJ	I _{AS} = 32A, L = 0.37mH

Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions							
I _S	Continuous Source Current			64		MOSFET symbol							
	(Body Diode)					04	Α	showing the					
I _{SM}	Pulsed Source Current			010		integral reverse							
	(Body Diode)①			210	210			- 210	210	210	210		p-n junction diode.
V _{SD}	Diode Forward Voltage			1.3	V	$T_J=25^\circ C,\ I_S=32A,\ V_{GS}=0V\ \textcircled{9}$							
t _{rr}	Reverse Recovery Time		68	100	ns	$T_{J} = 25^{\circ}C, I_{F} = 32A$							
Q _{rr}	Reverse Recovery Charge		220	330	nC	di/dt = 100A/µs ④							
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)											

Notes:

- $\ensuremath{\mathbb O}$ Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ④ Pulse width \leq 400µs; duty cycle \leq 2%.
- ⑤ This is the destructive value not limited to the thermal limit.
- ⑥ This is the thermal limited value.
- 0 Starting T_J = 25°C, L = 0.37mH R_G = 25 $\Omega,~I_{AS}$ = 32A. (See Figure 12)
- 3 I_{SD} \leq 32A, di/dt \leq 220A/µs, V_{DD} \leq V_{(BR)DSS}, T_J \leq 175°C
- ** When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended soldering techniques refer to application note #AN-994.



International

ICR Rectifier

Fig 1. Typical Output Characteristics

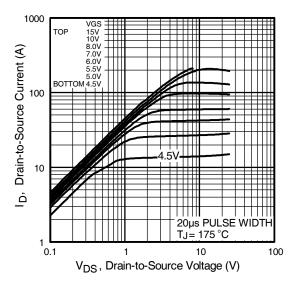


Fig 2. Typical Output Characteristics

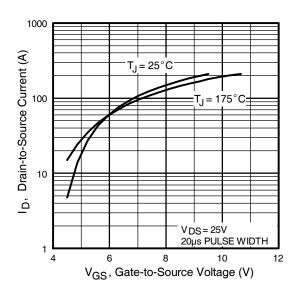


Fig 3. Typical Transfer Characteristics

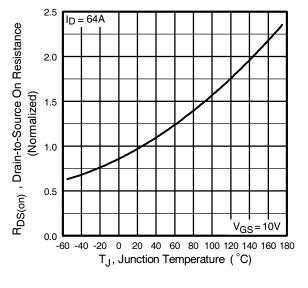


Fig 4. Normalized On-Resistance Vs. Temperature

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International

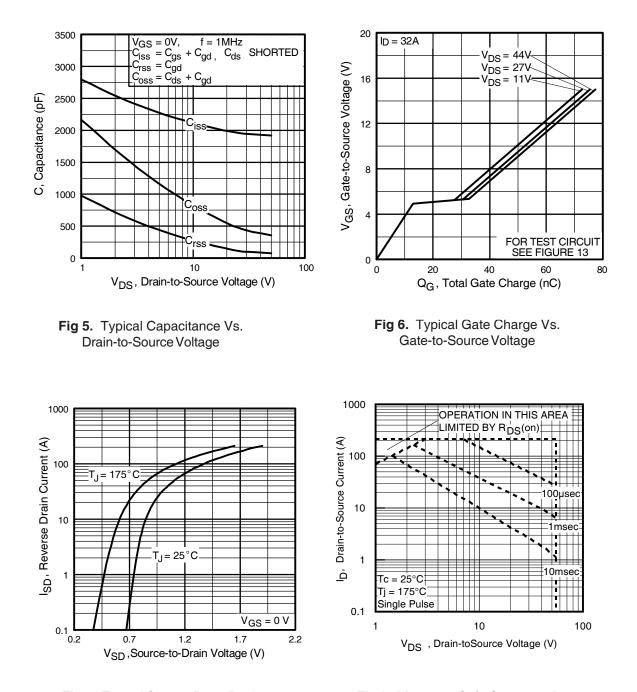
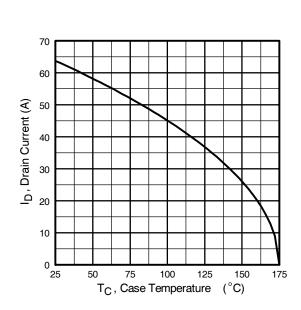


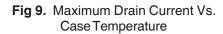


Fig 8. Maximum Safe Operating Area



International

TOR Rectifier



IRFZ48NS/LPbF

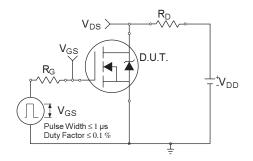


Fig 10a. Switching Time Test Circuit

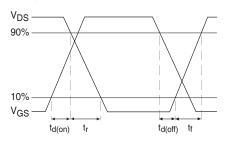


Fig 10b. Switching Time Waveforms

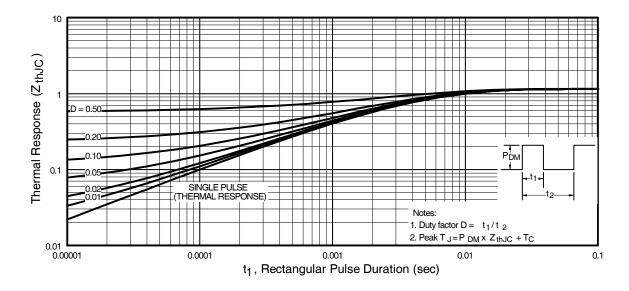


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

International

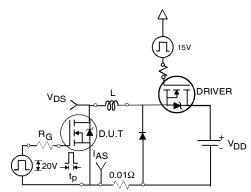


Fig 12a. Unclamped Inductive Test Circuit

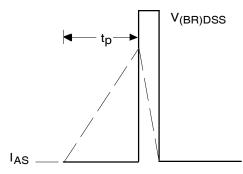
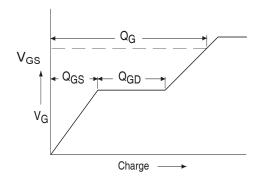


Fig 12b. Unclamped Inductive Waveforms





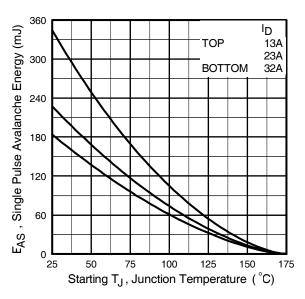


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

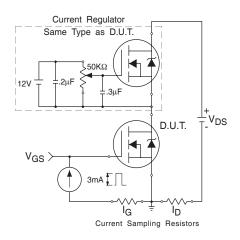
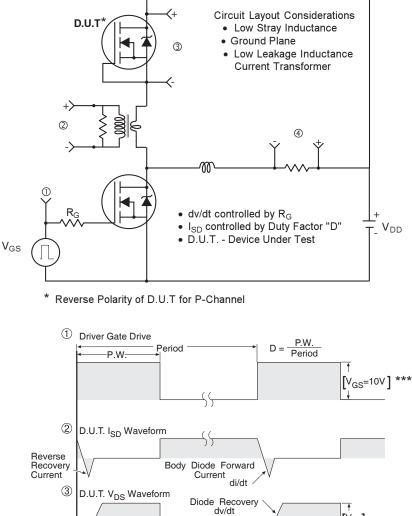


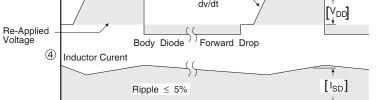
Fig 13b. Gate Charge Test Circuit

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IRFZ48NS/LPbF

Peak Diode Recovery dv/dt Test Circuit



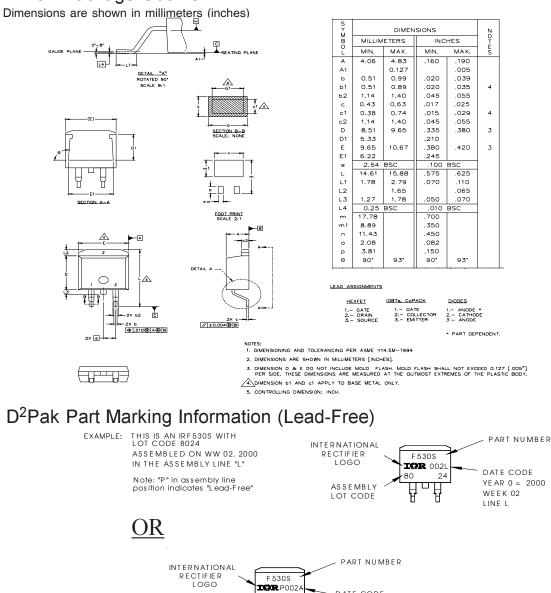


*** V_{GS} = 5.0V for Logic Level and 3V Drive Devices

Fig 14. For N-channel HEXFET® power MOSFETs

International TOR Rectifier

D²Pak Package Outline



80

ASSEMBLY

LOT CODE

Ηu

24

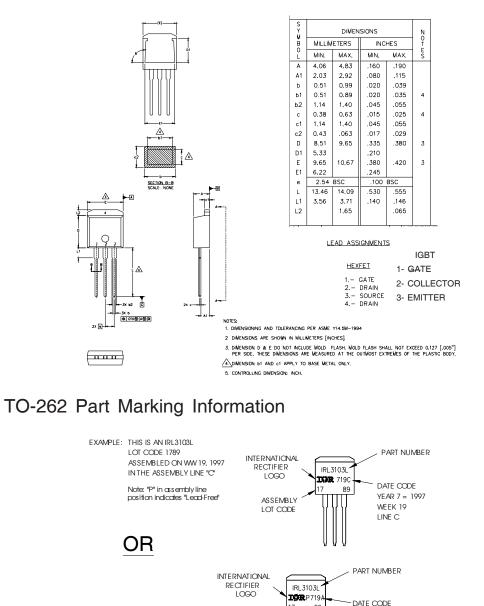
P

DATE CODE

DATE CODE P = DESIGNATES LEAD-FREE PRODUCT (OPTIONAL) YEAR 0 = 2000 WEEK 02 A = ASSEMBLY SITE CODE

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TO-262 Package Outline



89

ASSEMBLY LOT CODE

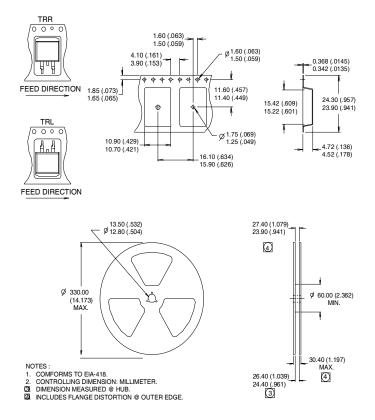
P = DESIGNATES LEAD-FREE PRODUCT (OPTIONAL) YEAR 7 = 1997

WEEK 19 A = ASSEMBLYSITE CODE



D²Pak Tape & Reel Infomation

Dimensions are shown in millimeters (inches)



Data and specifications subject to change without notice. This product has been designed and qualified for the industrial market. Qualification Standards can be found on IR's Web site.

International

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 TAC Fax: (310) 252-7903 Visit us at www.irf.com for sales contact information.03/04 10 www.irf.com Note: For the most current drawings please refer to the IR website at: <u>http://www.irf.com/package/</u>

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